

# MC8069

## Features

- Low Bias Current (Min) .....50μA
- Low Dynamic Impedance
- Low Reverse Voltage
- Low Cost

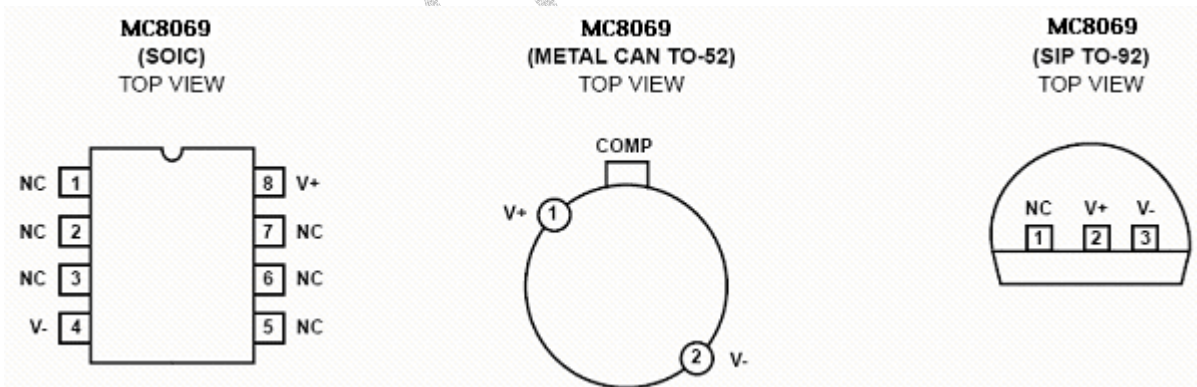
## Description

The MC8069 is a 1.2V temperature-compensated voltage reference. It uses the band-gap principle to achieve excellent stability and low noise at reverse currents down to 50μA. Applications include analog-to-digital converters, digital-toanalog converters, threshold detectors, and voltage regulators. Its low power consumption makes it especially suitable for battery operated equipment.

## Ordering Information

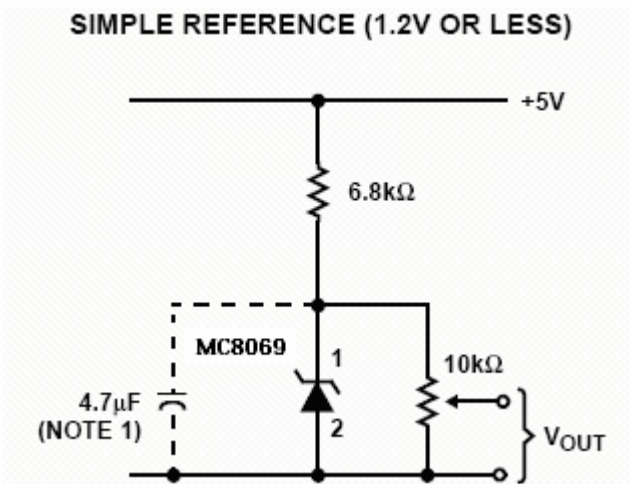
PART NUMBER	MAXIMUM TEMPCO	TEMP. RANGE (°C)	PACKAGE	PKG. NO.
ICL8069CCZR	0.005%/°C	0 to 70	SIP Package (TO-92)	Z3.05
ICL8069CCSQ	0.005%/°C	0 to 70	Metal Can Package (TO-52)	T2.A
ICL8069DCZR	0.01%/°C	0 to 70	SIP Package (TO-92)	Z3.05
ICL8069DCSQ	0.01%/°C	0 to 70	Metal Can Package (TO-52)	T2.A
ICL8069CCBA	0.005%/°C	0 to 70	8 Ld SOIC	M8.15
ICL8069DCBA	0.01%/°C	0 to 70	8 Ld SOIC	M8.15
ICL8069CMSQ	0.005%/°C	-55 to 125	Metal Can Package (TO-52)	T2.A
ICL8069DMSQ	0.01%/°C	-55 to 125	Metal Can Package (TO-52)	T2.A

## Pinouts

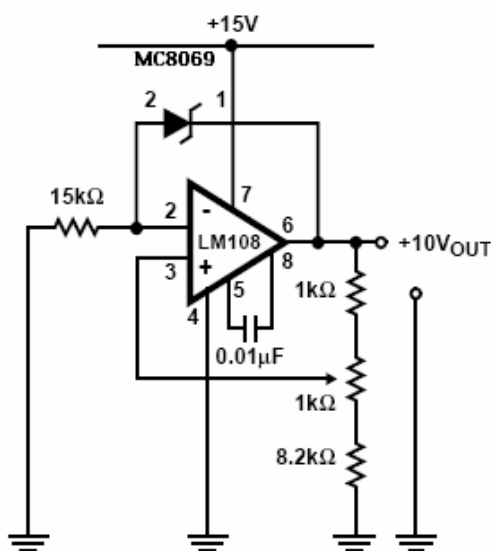


**Functional Block Diagrams**

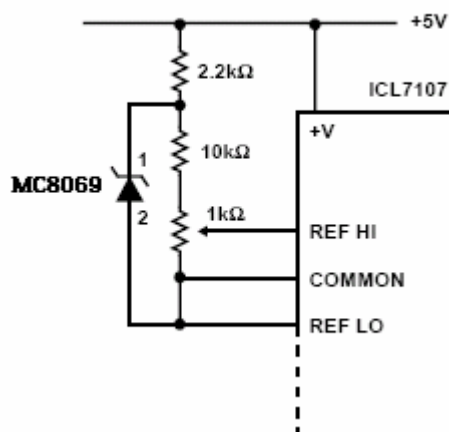
**SIMPLE REFERENCE (1.2V OR LESS)**



**BUFFERED 10V REFERENCE USING A SINGLE SUPPLY**



**DOUBLE REGULATED 100mV REFERENCE FOR ICL7107 ONE-CHIP DPM CIRCUIT**



### Absolute Maximum Ratings

Reverse Voltage	See Note 3
Forward Current	10mA
Reverse Current	10mA

### Operating Conditions

#### Temperature Ranges

MC8069C	0oC to 70oC
MC8069M	-55oC to 125oC

### Thermal Information

Thermal Resistance (Typical, Note 1)  $\theta_{JA}$  (oC/W)  $\theta_{JC}$  (oC/W)

SOIC Package 170 N/A

SIP (TO-92) Package 200 N/A

Metal Can Package 200 120

Power Dissipation Limited by MAX Forward/Reverse Current

Maximum Junction Temperature (Metal Can Package) 175oC

Maximum Junction Temperature (SOIC Package) 150oC

Maximum Storage Temperature Range -65oC to 150oC

Maximum Lead Temperature (Soldering 10s) 300oC

(SOIC - Lead Tips Only)

CAUTION: Stresses above those listed in "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress only rating and operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied.

NOTE:

1.  $\theta_{JA}$  is measured with the component mounted on an evaluation PC board in free air.

PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNITS
Reverse Breakdown Voltage	$I_R = 500\mu A$	1.20	1.23	1.25	V
Reverse Breakdown Voltage Change	$50\mu A \leq I_R \leq 5mA$	-	15	20	mV
Reverse Dynamic Impedance	$I_R = 50\mu A$	-	1	2	$\Omega$
	$I_R = 500\mu A$	-	1	2	$\Omega$
Forward Voltage Drop	$I_F = 500\mu A$	-	0.7	1	V
RMS Noise Voltage	$10Hz \leq F \leq 10kHz, I_R = 500\mu A$	-	5	-	$\mu V$
Long Term Stability	$I_R = 4.75mA, T_A = 25^\circ C$	-	1	-	ppm/kHR
Breakdown Voltage Temperature Coefficient	$I_R = 500\mu A, T_A = \text{Operating Temperature Range (Note 3)}$	-	-	0.005	%/oC
		-	-	0.01	%/oC
Reverse Current Range	1.18V to 1.27V	0.050	-	5	mA

NOTES:

1. If circuit strays in excess of 200pF are anticipated, a 4.7 $\mu$ F shunt capacitor will ensure stability under all operating conditions.
2. In normal use, the reverse voltage cannot exceed the reference voltage. However when plugging units into a powered-up test fixture, an instantaneous voltage equal to the compliance of the test circuit will be seen. This should not exceed 20V.
3. For the military part, measurements are made at 25oC, -55oC, and 125oC. The unit is then classified as a function of the worst case TC from 25oC to -55oC, or 25oC to 125oC.

**Typical Performance Curves**

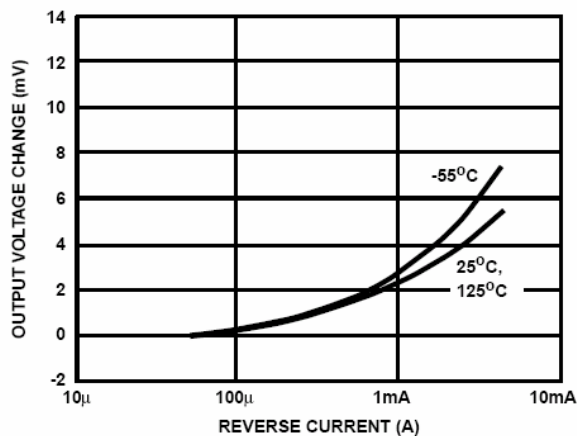


FIGURE 1. VOLTAGE CHANGE AS A FUNCTION OF REVERSE CURRENT

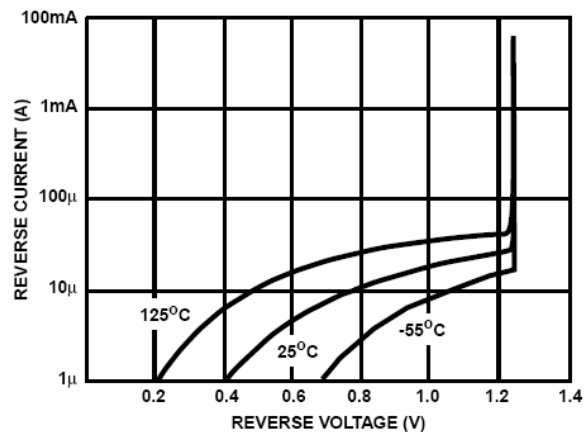


FIGURE 2. REVERSE VOLTAGE AS A FUNCTION OF CURRENT

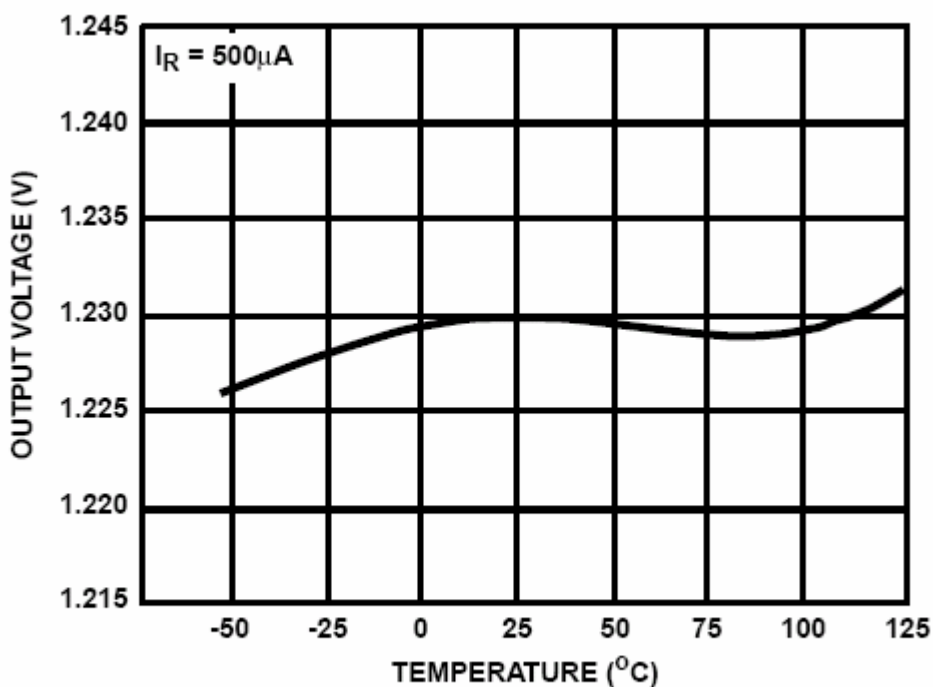


FIGURE 3. REVERSE VOLTAGE AS A FUNCTION OF TEMPERATURE